

Notice of References Cited

Application/Control No.

10/574,350

Applicant(s)/Patent Under
Reexamination
SCHWOERER, LUDWIG

Examiner

BENJAMIN ELLIOTT

Art Unit

2474

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,563,914 A	10-1996	Sogabe, Yasushi	375/326
*	B	US-5,790,784 A	08-1998	Beale et al.	370/520
*	C	US-6,115,427 A	09-2000	Calderbank et al.	375/267
*	D	US-6,125,124 A	09-2000	Junell et al.	370/503
*	E	US-6,359,938 B1	03-2002	Keavill et al.	375/316
*	F	US-6,363,128 B1	03-2002	Isaksson et al.	375/355
*	G	US-2002/0044540 A1	04-2002	Mottier et al.	370/335
*	H	US-6,470,030 B1	10-2002	Park et al.	370/480
*	I	US-2002/0144294 A1	10-2002	Rabinowitz et al.	725/139
*	J	US-2003/0072254 A1	04-2003	Ma et al.	370/208
*	K	US-2003/0123407 A1	07-2003	ARIMITSU, KAZUHIRO	370/335
*	L	US-2003/0152157 A1	08-2003	Antoine et al.	375/260
*	M	US-2003/0174643 A1	09-2003	Ro et al.	370/210

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/574,350		Applicant(s)/Patent Under Reexamination SCHWOERER, LUDWIG	
	Examiner BENJAMIN ELLIOTT		Art Unit 2474	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0057400 A1	03-2004	Walsh et al.	370/329
*	B	US-2004/0228270 A1	11-2004	Chen et al.	370/210
*	C	US-6,822,953 B1	11-2004	Schaefer et al.	370/344
*	D	US-2004/0233838 A1	11-2004	Sudo et al.	370/208
*	E	US-2005/0129155 A1	06-2005	Hoshino, Hironobu	375/347
*	F	US-6,904,030 B2	06-2005	Lee et al.	370/335
*	G	US-6,930,989 B1	08-2005	Jones IV et al.	370/335
*	H	US-2005/0174929 A1	08-2005	Hayashi et al.	370/208
*	I	US-2005/0220001 A1	10-2005	Henriksson, Jukka Allan	370/208
*	J	US-6,993,003 B2	01-2006	Huber, Johann	370/335
*	K	US-7,061,881 B2	06-2006	Mottier et al.	370/318
*	L	US-2006/0116095 A1	06-2006	Henriksson, Jukka	455/223
*	M	US-2006/0114812 A1	06-2006	Kim et al.	370/206

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No. 10/574,350	Applicant(s)/Patent Under Reexamination SCHWOERER, LUDWIG	
		Examiner BENJAMIN ELLIOTT	Art Unit 2474	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0146867 A1	07-2006	Lee et al.	370/465
*	B	US-7,130,313 B2	10-2006	Pekonen, Harri	370/473
*	C	US-7,133,479 B2	11-2006	Lee, Tsung-Lin	375/354
*	D	US-7,177,376 B2	02-2007	Atungsir et al.	375/343
*	E	US-7,184,495 B2	02-2007	Thomson et al.	375/340
*	F	US-2007/0053281 A1	03-2007	Schworer, Ludwig	370/208
*	G	US-7,221,720 B2	05-2007	Robinson, Adrian Paul	375/341
*	H	US-7,248,559 B2	07-2007	Ma et al.	370/208
*	I	US-7,286,794 B2	10-2007	Van Rooyen, Pieter	455/3.06
*	J	US-7,283,498 B2	10-2007	Ro et al.	370/333
*	K	US-7,313,209 B2	12-2007	Antoine et al.	375/354
*	L	US-7,310,393 B2	12-2007	Sheu et al.	375/348
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.